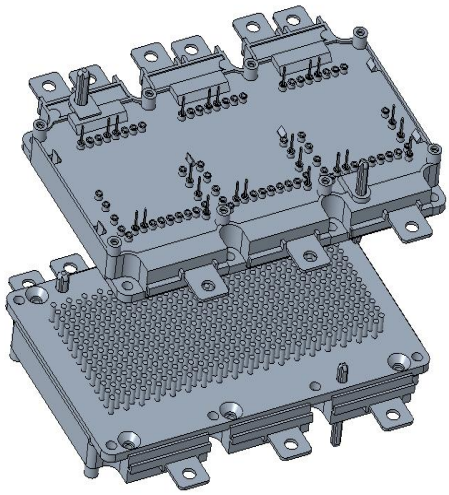
CHONGQING CLOUDCHILD TECHNOLOGY CO.,LTD

HPD IGBT POWER MODULE

CCGH820T75SD Trench-FS IGBT power module

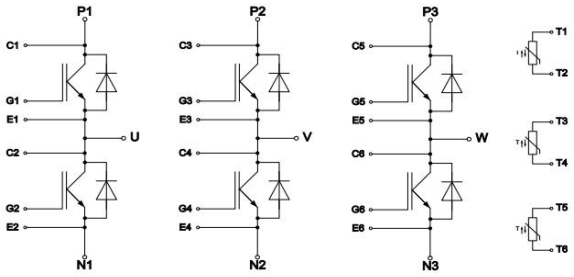
V_{CES}	V_{CEsat}		I_{CN}/I_{CRM}
750V	T_{vj}=25℃@450A	1.40V	820A/1640A
	T_{vj}=175℃@450A	1.58V	



DESCRIPTION

This IGBT power module adopts a very compact six-pack (750V/820A) optimized for hybrid and electric vehicles. Due to the high clearance and creepage distances, the module is also well suited for increased system working voltages and supports modular inverter approaches.

EQUIVALENT CIRCUIT



FEATURES

- Increased blocking voltage to 750V
- Increased DC link Voltage
- High short circuit capability
- Self-limiting short circuit current
- High surge current capability
- High current density
- Ultra low conduction and switching loss
- Ultra-fast & soft recovery anti-parallel FRD
- Trench-FS IGBT technology
- High Power Density
- Emitter Controlled Diode
- Integrated NTC temperature sensor
- High creepage and clearance distances
- Direct cooled PinFin base plate
- Guiding elements for PCB and cooler assembly
- AQG324 Qualified

APPLICATIONS

- Motor Drives
- Hybrid Electrical Vehicles(H)EV
- Commercial Agriculture Vehicles
- Automotive applications

CHARACTERISTICS VALUES

MAXIMUM RATED VALUES(IGBT)

Parameter	Symbol	Conditions	Values	Units
Collector-emitter voltage	V_{CES}	T_{vj}=25℃, V_{GE}=0V	750	V
Implemented collector current	I_{CN}		820	A
Continuous DC collector current	$I_{C\ nom}$	T_F=80℃, $T_{vj\ max}$=175℃	450[1)]	A
Repetitive peak collector current	I_{CRM}	t_p=1ms, T_{vj}=25℃	1640	A
Gate-emitter peak voltage	V_{GES}	T_{vj}=25℃	±30	V
SC data	I_{SC}	V_{GE}≤15V, V_{CC}=400V, V_{CEmax}=V_{CES}-L_{sCE}*di/dt t_p≤5μs, T_{vj}=150℃	4000	A
Total power dissipation	P_{tot}	T_F=75℃, $T_{vj\ max}$=175℃	667[1)]	W

1）Verified by characterization / design not by test.

CHARACTERISTICS VALUES(IGBT)

Parameter	Symbol	Conditions		Values			Units
				Min.	Typ.	Max.	
Collector-emitter saturation voltage	V_{CEsat}	I_C=450A, V_{GE}=15V, T_{vj}=25℃		1.2	1.40	1.6	V
		I_C=450A, V_{GE}=15V, T_{vj}=150℃			1.55		V
		I_C=450A, V_{GE}=15V, T_{vj}=175℃			1.58		V
		I_C=820A, V_{GE}=15V, T_{vj}=25℃		1.6	1.8	2.0	V
		I_C=820A, V_{GE}=15V, T_{vj}=150℃			2.0		V
		I_C=820A, V_{GE}=15V, T_{vj}=175℃			2.1		V
Gate-emitter threshold voltage	V_{GEth}	V_{CE}=V_{GE}, I_C=10mA	T_{vj}=25℃	5.0	6.1	7.0	V
			T_{vj}=175℃		3.8		V
Gate charge	Q_G	V_{GE}=-8V...+15V, V_{CE} = 400V			4.3		uC
Integrated gate resistor	R_G	T_{vj}=25℃			1		Ω
Input capacitance	C_{ies}	T_{vj}=25℃,f=100KHz,V_{GE}=0V,V_{CE}=25V			38		nF
Output capacitance	C_{oes}	T_{vj}=25℃,f=100KHz,V_{GE}=0V,V_{CE}=25V			1.82		nF
Reverse transfer capacitance	C_{res}	T_{vj}=25℃,f=100KHz,V_{GE}=0V,V_{CE}=25V			0.23		nF
Collector-emitter cut-off current	I_{CES}	V_{CE}=750V, V_{GE}=0V	T_{vj}=25℃			1	mA
			T_{vj}=175℃		4		mA
Gate-emitter leakage current	I_{GES}	V_{CE}=0V, V_{GE}=20V, T_{vj}=25℃				400	nA
Turn-on delay time, inductive load	$t_{d\ on}$	I_C=450A, V_{CE}=400V, V_{GE}=-8V/+15V, R_{Gon}=5Ω, R_{Goff}=5Ω	T_{vj}=25℃		248		ns
			T_{vj}=150℃		255		ns
			T_{vj}=175℃		265		ns
Rise time, inductive load	t_r		T_{vj}=25℃		88		ns
			T_{vj}=150℃		101		ns
			T_{vj}=175℃		105		ns
Turn-off delay time, inductive load	$t_{d\ off}$		T_{vj}=25℃		509		ns
			T_{vj}=150℃		662		ns
			T_{vj}=175℃		670		ns

Fall time, inductive load	t_f		T_{vj}=25℃		111		ns
			T_{vj}=150℃		122		ns
			T_{vj}=175℃		130		ns
Turn-on energy loss per pulse	E_{on}	I_C=450A, V_{CE}=400V, V_{GE}=-8V/+15V,R_{Gon}=5Ω,L_s=20nH,di/dt(Tvj25°)=4300A/μs,	T_{vj}=25℃		16.5		mJ
			T_{vj}=150℃		20.5		mJ
			T_{vj}=175℃		21.9		mJ
Turn-off energy loss per pulse	E_{off}	I_C=450A, V_{CE}=400V, V_{GE}=-8V/+15V,R_{Goff}=5Ω,L_s=20nH,dv/dt(Tvj25°)=7100A/μs	T_{vj}=25℃		22.2		mJ
			T_{vj}=150℃		27.5		mJ
			T_{vj}=175℃		28.7		mJ
IGBT, thermal resistance, junction to cooling fluid	$R_{thjF\ IGBT}$	per IGBT,ΔV/Δt =10 dm³/min, T_F = 75°C				0.15	K/W

MAXIMUM RATED VALUES(Diode)

Parameter	Symbol	Conditions	Values	Units
Repetitive peak reverse voltage	V_{RRM}	T_{vj}=25℃	750	V
Implemented forward current	I_{FN}		820	A
Continuous DC forward current	I_F		450[1)]	A
Repetitive peak forward current	I_{FRM}	t_p=1ms	1640	A
I^2t-value	I^2t	V_R=0V, t_p=10ms, T_{vj}=150℃	18000	A^2s
		V_R=0V, t_p=10ms, T_{vj}=175℃	15500	A^2s

1) Verified by characterization / design not by test.

CHARACTERISTICS VALUES(Diode)

Parameter	Symbol	Conditions		Values			Units
				Min.	Typ.	Max.	
Forward voltage	V_F	I_F=450A, V_{GE}=0V	T_{vj}=25℃		1.5	1.85	V
			T_{vj}=150℃		1.45		V
			T_{vj}=175℃		1.43		V
Peak reverse recovery current	I_{RM}	I_F=450A, V_R=400V, V_{GE}=-8V/+15V，-di$_F$/dt=5000A/μs (T_{vj}=25℃)	T_{vj}=25℃		195		A
			T_{vj}=150℃		300		A
			T_{vj}=175℃		320		A
Recovered charge	Q_r		T_{vj}=25℃		12.17		μC
			T_{vj}=150℃		29.5		μC
			T_{vj}=175℃		37.2		μC
Reverse recovery energy	E_{rec}		T_{vj}=25℃		3.7		mJ
			T_{vj}=150℃		6.8		mJ
			T_{vj}=175℃		7.4		mJ
Diode, thermal resistance, junction to cooling fluid	$R_{thjF\ Diode}$	per diode,ΔV/Δt =10 dm³/min, T_F = 75°C				0.19	K/W

NTC-THERMISTOR

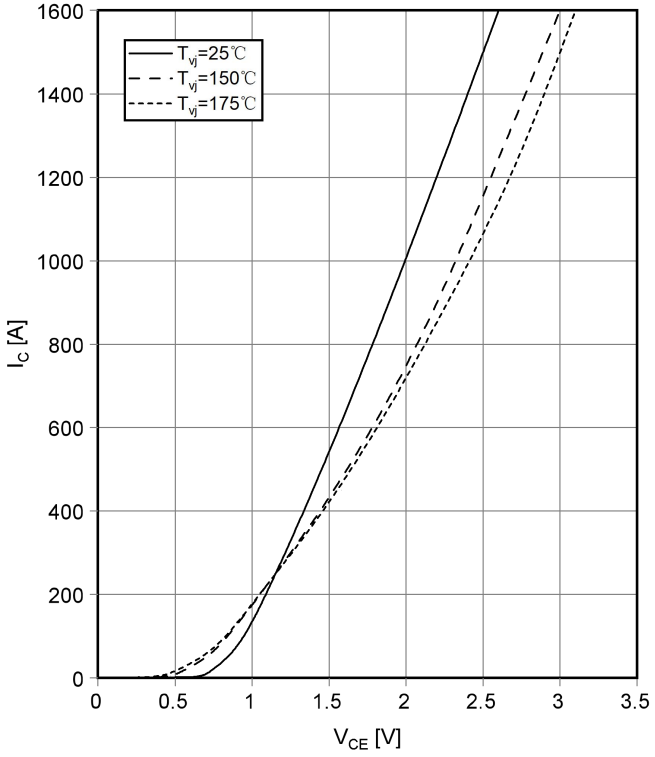
Parameter	Symbol	Conditions	Values			Units
			Min.	Typ.	Max.	
Rated resistance	R_{25}	T_C=25℃		5.0		KΩ
Deviation of R100	△R/R	T_C=100℃, R_{100}=493Ω	-3		3	%
Power dissipation	P_{25}	T_C=25℃			60	mW
B-value	$B_{25/50}$	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15K))]$		3375		K
B-value	$B_{25/80}$	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15K))]$		3411		K
B-value	$B_{25/100}$	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15K))]$		3433		K

MODULE

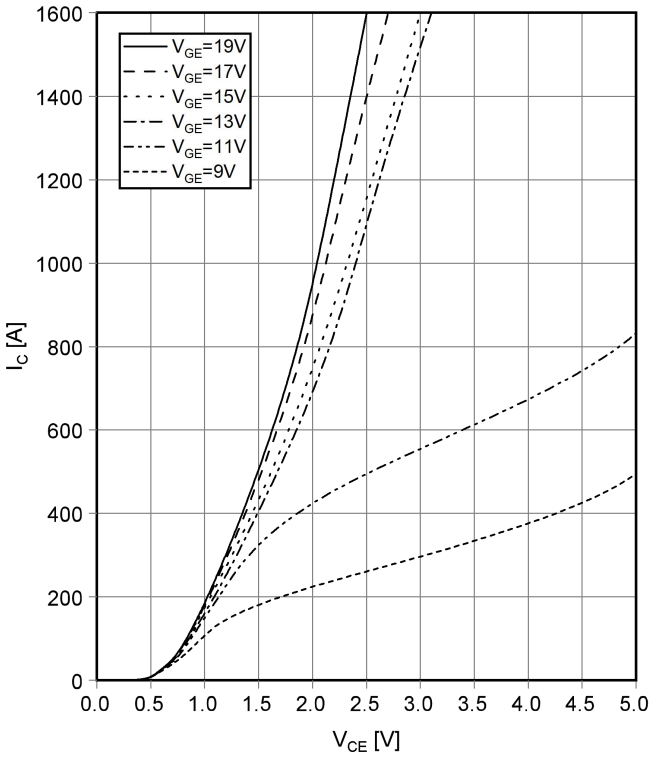
Parameter	Symbol	Conditions	Values			Units
			Min.	Typ.	Max.	
Maximum junction temperature	$T_{vj\ max}$				175	℃
Temperature under switching conditions	$T_{vj\ op}$		-40		175	℃
Storage temperature	T_{stg}		-40		150	℃
Stray inductance module	L_{sCE}			7		nH
Module lead resistance, terminals-chip	$R_{CC'+EE}$	T_{vj}=25℃, per switch		0.9		mΩ
Isolation test voltage	V_{isol}	AC, RMS, f=50Hz, t=1min		3.5		kV
Creepage distance	ds	Terminal to terminal		9.0		mm
		Terminal to base		9.0		mm
Clearance distance in air	da	Terminal to terminal		4.5		mm
		Terminal to base		4.5		mm
Comperative tracking index	CTI			>200		
Mounting torque for module mounting	M1	Screw M4 baseplate to heatsink	1.8	2.0	2.2	N·m
	M2	Screw M4 EJOT Delta PCB to frame	0.45	0.50	0.55	
Terminal connection torque	M3	Screw M5	3		6	
Internal isolation	-	Basic insulation (class1, IEC 61140)		Al_2O_3		-
Material of module baseplate	-			Cu+Ni		-
Dimensions	L x W x H			154.5x126.5x32		mm
Weight	G			720		g

CHARACTERISTICS DIAGRAMS

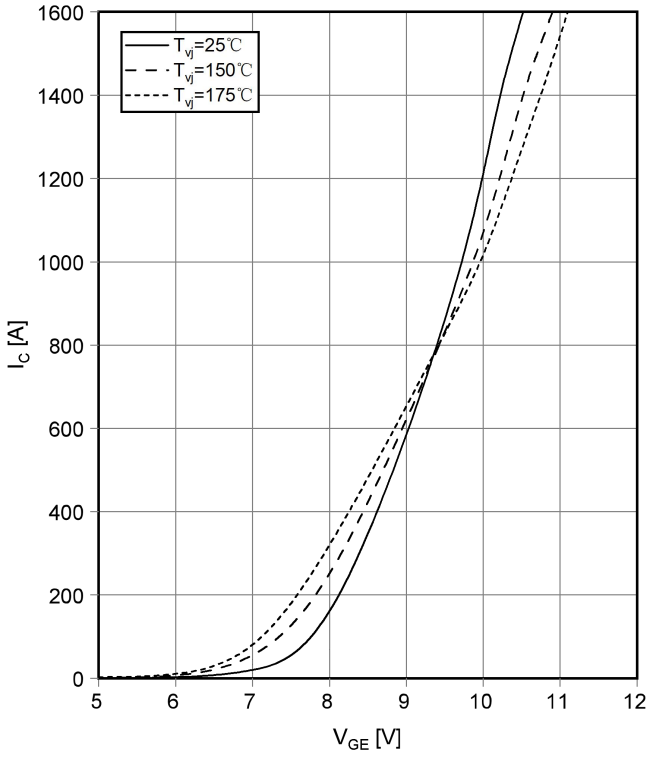
Output characteristic IGBT, Inverter(typical)
$I_C=f(V_{CE}),V_{GE}=15V$



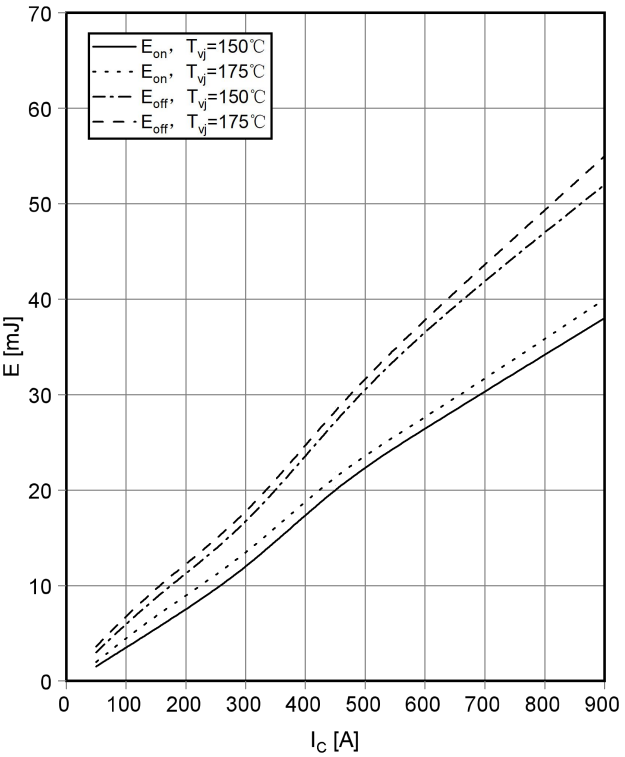
Output characteristic IGBT, Inverter(typical)
$I_C=f(V_{CE}),T_{vj}$=150℃



Transfer characteristic IGBT, Inverter(typical)
$I_C=f(V_{GE}),V_{CE}$=20V

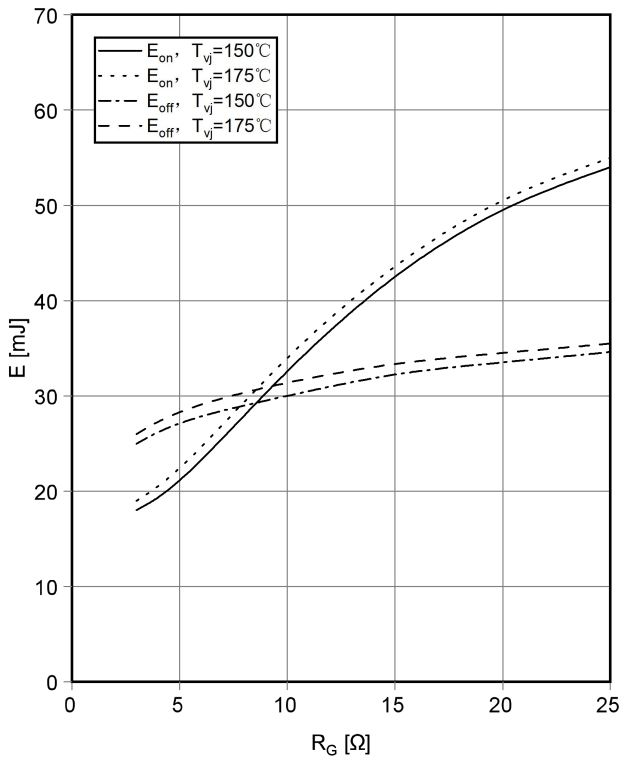


Switching losses IGBT, Inverter(typical)
$E_{on}=f(I_C)$, $E_{off}=f(I_C)$ V_{GE}=-8V/+15V, $R_{Gon}=R_{Goff}$=5Ω, V_{CE}=400V



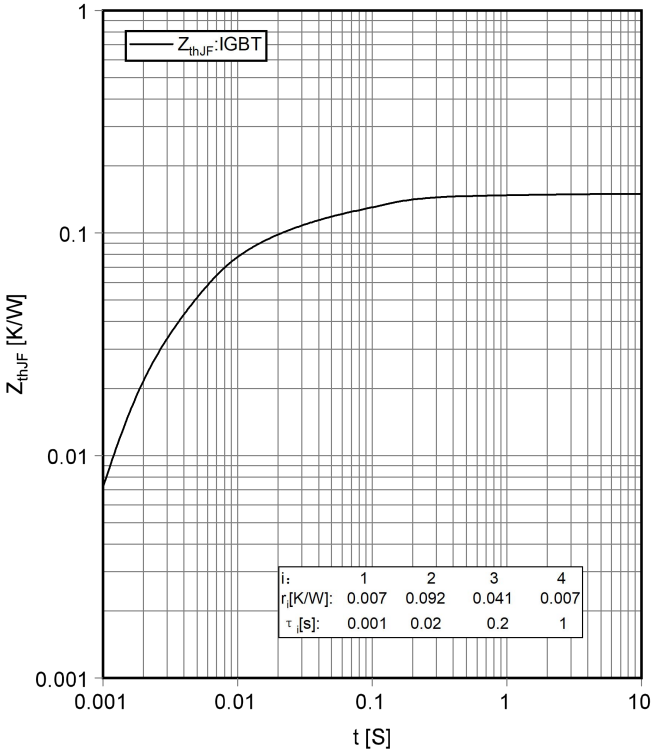
Switching losses IGBT, Inverter(typical)

$E_{on}=f(R_G)$, $E_{off}=f(R_G)$ V_{GE}=-8V/+15V, I_C=450A, V_{CE}=400V



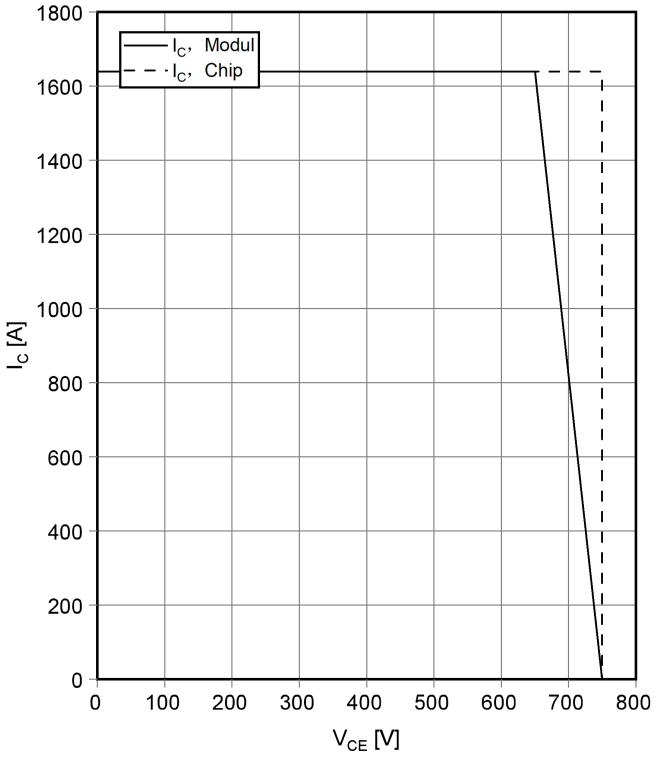
Transient thermal impedance IGBT, Inverter

$Z_{thJF}=f(t)$



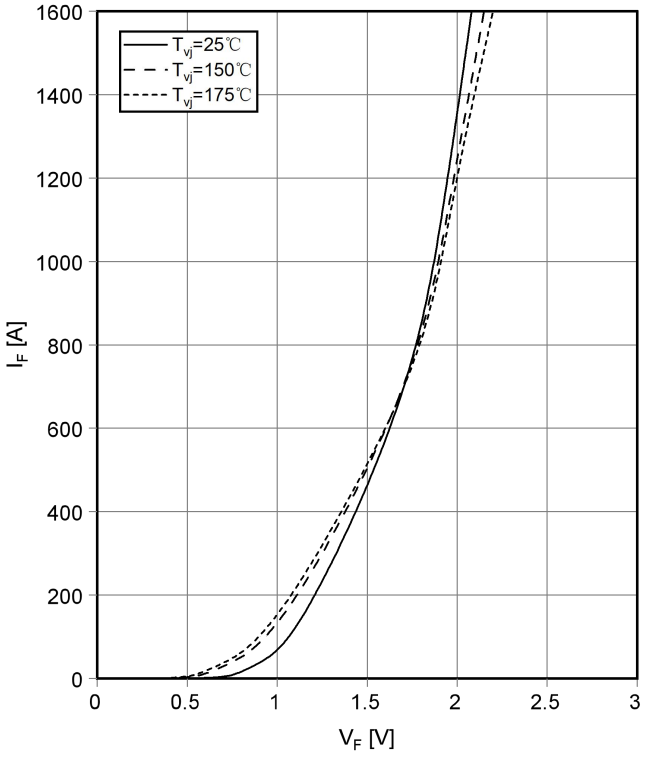
Reverse bias safe operating area IGBT, Inverter(RBSOA)

$I_C=f(V_{CE})$, V_{GE}=±15V, R_{Goff}=5Ω, T_{vj}=150℃

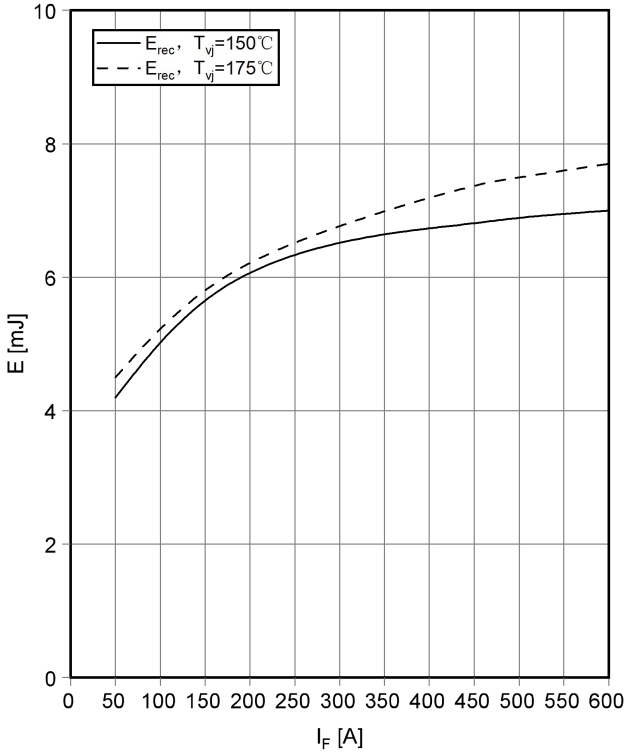


Forward characteristic of Diode, Inverter(typical)

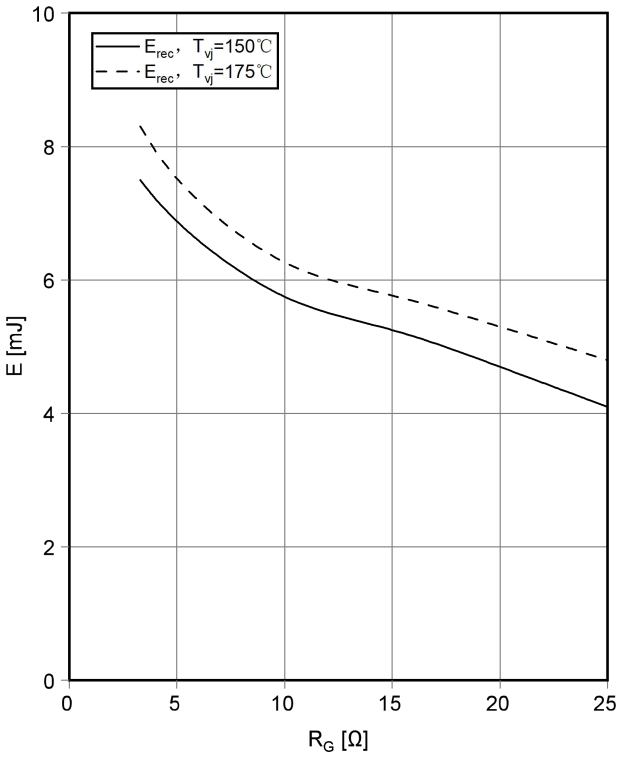
$I_F=f(V_F)$



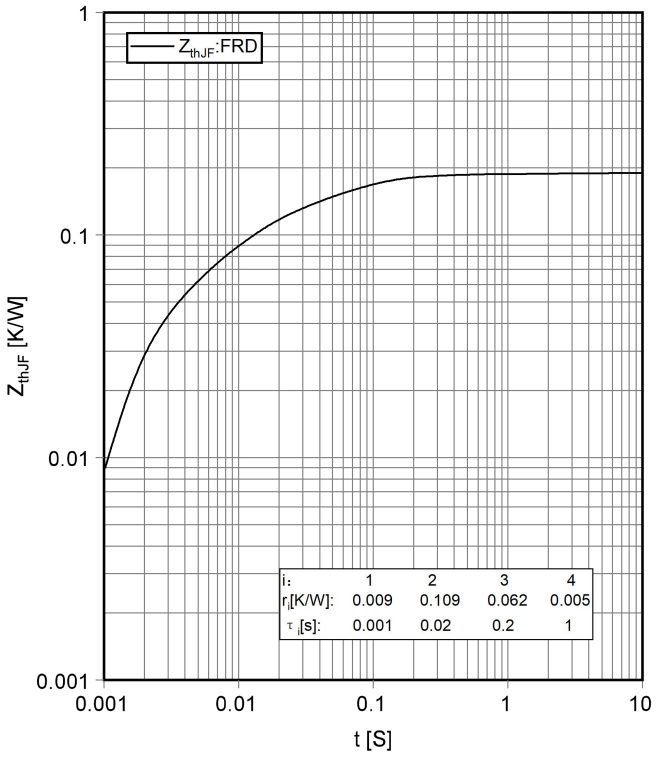
Switching losses Diode, Inverter(typical)
$E_{rec}=f(I_F)$, $R_{Gon}=5\Omega$, $V_{CE}=400V$



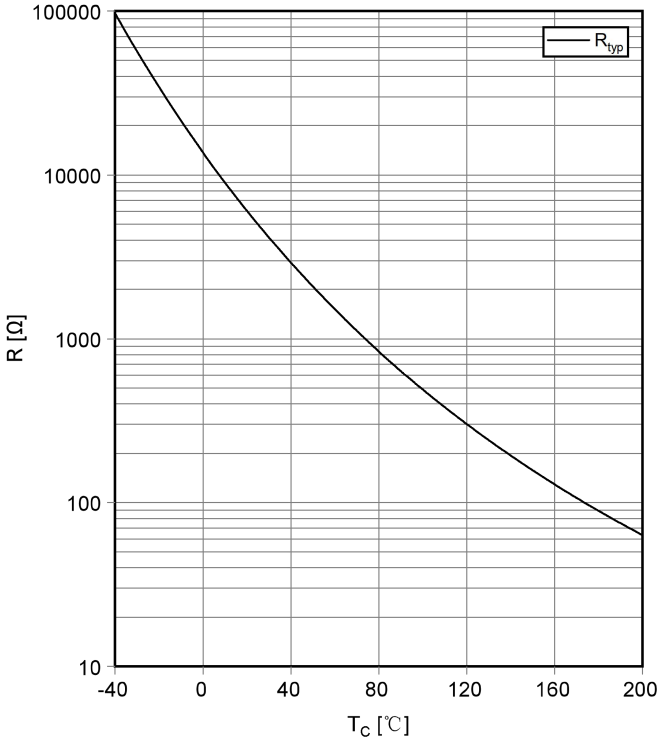
Switching losses Diode, Inverter(typical)
$E_{rec}=f(R_G)$, $I_F=450A$, $V_{CE}=400V$



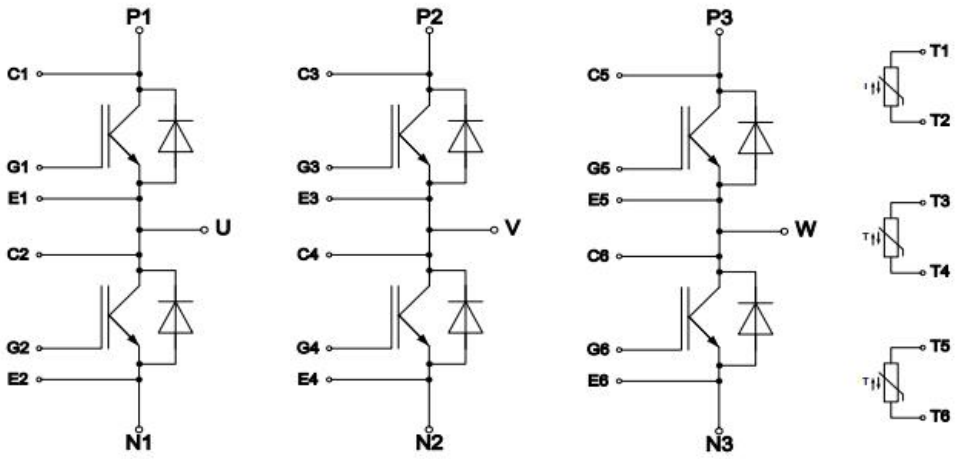
Transient thermal impedance Diode, Inverter
$Z_{thJF}=f(t)$



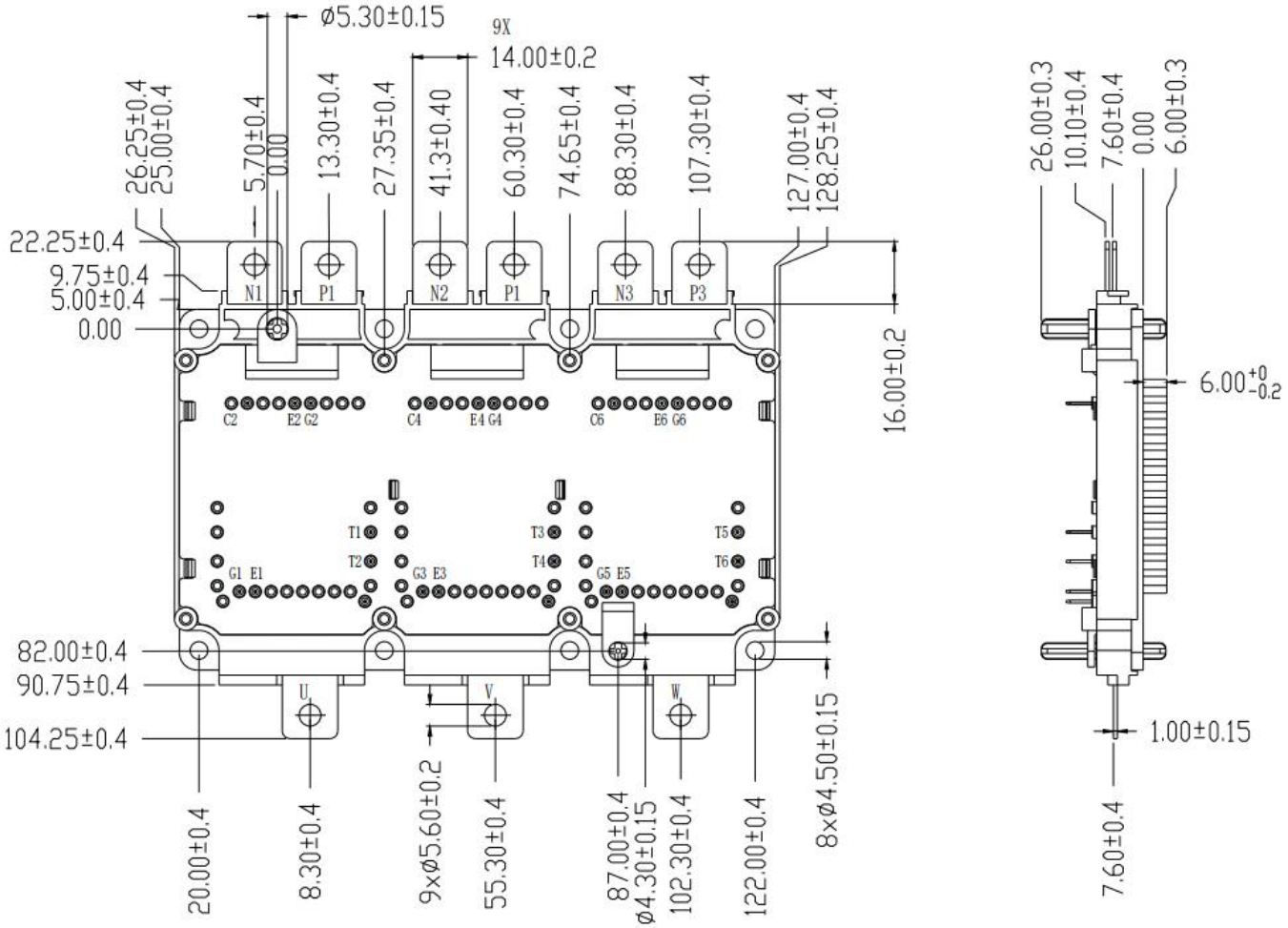
NTC-Thermistor-temperature, characteristic(typical)
R=f(T)

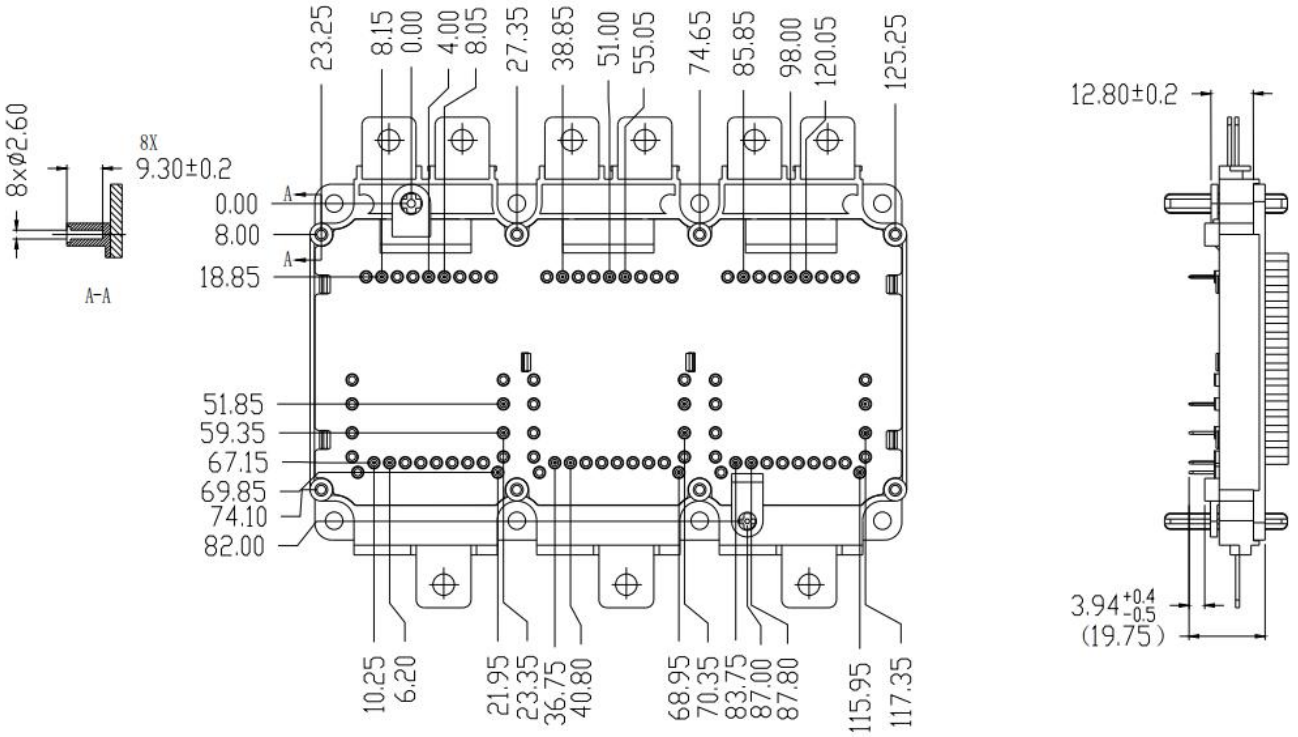


CIRCUIT DIAGRAM



PACKAGE OUTLINES





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Date of change	Rev #	revise content
2023/04/21	A/0	Initial releases
2023/08/16	A/1	升级规格书